

EVALUATION KIT
AVAILABLE**MAXIM****Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL****General Description**

The MAX5856A dual, 8-bit, 300Msps digital-to-analog converter (DAC) provides superior dynamic performance in wideband communication systems. The MAX5856A integrates two 8-bit DAC cores, 4x/2x/1x programmable digital interpolation filters, phase-lock loop (PLL) clock multiplier, and a 1.24V reference. The MAX5856A supports single-ended and differential modes of operation. The MAX5856A dynamic performance is maintained over the entire power-supply operating range of 2.7V to 3.3V. The analog outputs support a compliance voltage of -1.0V to +1.25V.

The 4x/2x/1x programmable interpolation filters feature excellent passband distortion and noise performance. Interpolating filters minimize the design complexity of analog reconstruction filters while lowering the data bus and the clock speeds of the digital interface. The PLL multiplier generates all internal synchronized high-speed clock signals for interpolating filter operation and DAC core conversion. The internal PLL helps minimize system complexity and lower cost. To reduce the I/O pin count, the DAC can also operate in interleave data mode. This allows the MAX5856A to be updated on a single 8-bit bus.

The MAX5856A features digital control of channel gain matching to within $\pm 0.4\text{dB}$ in sixteen 0.05dB steps. Channel matching improves sideband suppression in analog quadrature modulation applications. The on-chip 1.24V bandgap reference includes a control amplifier that allows external full-scale adjustments of both channels through a single resistor. The internal reference can be disabled and an external reference may be applied for high-accuracy applications.

The MAX5856A features full-scale current outputs of 2mA to 20mA and operates from a 2.7V to 3.3V single supply. The DAC supports three modes of power-control operation: normal, low-power standby, and complete power-down. In power-down mode, the operating current is reduced to 1 μA .

The MAX5856A is packaged in a 48-pin TQFP with exposed paddle (EP) for enhanced thermal dissipation and is specified for the extended (-40°C to +85°C) operating temperature range.

Applications

Communications

SATCOM, LMDS, MMDS, HFC, DSL, WLAN,
Point-to-Point Microwave Links

Wireless Base Stations

Direct Digital Synthesis

Instrumentation/ATE

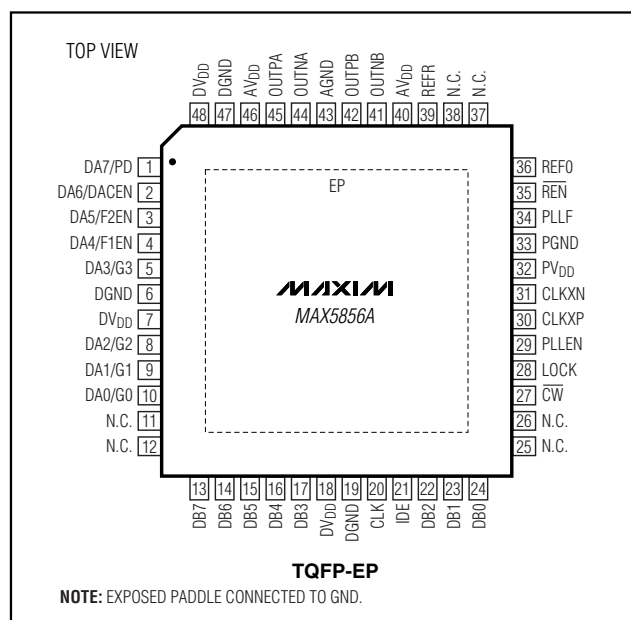
Features

- ◆ 8-Bit Resolution, Dual DAC
- ◆ 300Msps Update Rate
- ◆ Integrated 4x/2x/1x Interpolating Filters
- ◆ Internal PLL Multiplier
- ◆ 2.7V to 3.3V Single Supply
- ◆ Full Output Swing and Dynamic Performance at 2.7V Supply
- ◆ Superior Dynamic Performance: 68dBc SFDR at $f_{\text{OUT}} = 20\text{MHz}$
- ◆ Programmable Channel Gain Matching
- ◆ Integrated 1.24V Low-Noise Bandgap Reference
- ◆ Single-Resistor Gain Control
- ◆ Interleave Data Mode
- ◆ Differential Clock Input Modes
- ◆ EV Kit Available—MAX5858AEVKIT

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX5856AECM	-40°C to +85°C	48 TQFP-EP*

*EP = Exposed paddle.

Pin Configuration**MAXIM**

Maxim Integrated Products 1

For pricing, delivery, and ordering information, please contact Maxim/Dallas Direct! at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

MAX5856A

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

ABSOLUTE MAXIMUM RATINGS

AVDD, DVDD, PVDD to AGND, DGND, PGND-0.3V to +4V
 DA7–DA0, DB7–DB0, $\overline{CW}$, $\overline{REN}$, PLLF, PLLEN to AGND,
 DGND, PGND-0.3V to +4V
 IDE to AGND, DGND, PGND-0.3V to (DVDD + 0.3V)
 CLKXN, CLKXP to PGND-0.3V to +4V
 OUTP_, OUTN_ to AGND-1.25V to (AVDD + 0.3V)
 CLK, LOCK to DGND-0.3V to (DVDD + 0.3V)
 REFR, REFO to AGND-0.3V to (AVDD + 0.3V)
 AGND to DGND, DGND to PGND,
 AGND to PGND-0.3V to +0.3V

Maximum Current into Any Pin
 (excluding power supplies)±50mA
 Continuous Power Dissipation (TA = +70°C)
 48-Pin TQFP-EP (derate 36.2mW/°C above +70°C)2.899W
 Operating Temperature Range-40°C to +85°C
 Storage Temperature Range-65°C to +150°C
 Junction Temperature+150°C
 Lead Temperature (soldering, 10s)+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(AVDD = DVDD = PVDD = 3V, AGND = DGND = PGND = 0, fDAC = 165Msps, no interpolation, PLL disabled, external reference, VREF0 = 1.2V, IFS = 20mA, output amplitude = 0dB FS, differential output, TA = TMIN to TMAX, unless otherwise noted. TA > +25°C, guaranteed by production test. TA < +25°C, guaranteed by design and characterization. Typical values are at TA = +25°C.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
STATIC PERFORMANCE							
Resolution				8			Bits
Integral Nonlinearity	INL	R _L = 0		-0.4	±0.15	+0.4	LSB
Differential Nonlinearity	DNL	Guaranteed monotonic, R _L = 0		-0.2	±0.07	+0.2	LSB
Offset Error	V _{OS}			-0.1	±0.03	+0.1	LSB
Gain Error (See the <i>Parameter Definitions</i> Section)	GE	Internal reference (Note 1)		-10	±1.2	+10	%
		External reference		-6.5	±0.8	+6.5	
DYNAMIC PERFORMANCE							
Maximum DAC Update Rate	f _{DAC}	4x/2x interpolation modes		300			Msps
Glitch Impulse				5			pV-s
Spurious-Free Dynamic Range to Input Update Rate Nyquist	SFDR	f _{DAC} = 165Msps	f _{OUT} = 5MHz, T _A ≥ +25°C	65	67	dBc	
			f _{OUT} = 20MHz	68			
			f _{OUT} = 50MHz	63			
			f _{OUT} = 70MHz	56			
		f _{DAC} = 300Msps, 2x interpolation	f _{OUT} = 5MHz	68			
			f _{OUT} = 40MHz	65			
			f _{OUT} = 60MHz	67			
Spurious-Free Dynamic Range Within a Window	SFDR	f _{DAC} = 200Msps, 2x interpolation, f _{OUT} = 40MHz, span = 20MHz		67			dBc
		f _{DAC} = 165Msps, f _{OUT} = 5MHz, span = 4MHz		68	72		
Multitone Power Ratio, 8 Tones, ~300kHz Spacing	MTPR	f _{DAC} = 165Msps, f _{OUT} = 20MHz		65			dBc
Total Harmonic Distortion to Nyquist	THD	f _{DAC} = 165Msps, f _{OUT} = 5MHz		70			dBc

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

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ELECTRICAL CHARACTERISTICS (continued)

(AVDD = DVDD = PVDD = 3V, AGND = DGND = PGND = 0, fDAC = 165Msps, no interpolation, PLL disabled, external reference, VREF0 = 1.2V, IFS = 20mA, output amplitude = 0dB FS, differential output, TA = TMIN to TMAX, unless otherwise noted. TA > +25°C, guaranteed by production test. TA < +25°C, guaranteed by design and characterization. Typical values are at TA = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Noise Spectral Density	nd	fDAC = 165Msps, fOUT = 5MHz		-133		dBm/Hz
Output Channel-to-Channel Isolation		fOUT = 5MHz		80		dB
Gain Mismatch Between Channels		fOUT = 5MHz		±0.05		dB
Phase Mismatch Between Channels		fOUT = 5MHz		±0.15		Degrees
Wideband Output Noise				50		pA/√Hz
ANALOG OUTPUT						
Full-Scale Output Current Range	IFS		2		20	mA
Output Voltage Compliance Range			-1.0		+1.25	V
Output Leakage Current		Power-down or standby mode	-5		+5	μA
REFERENCE						
Reference Output Voltage	VREF0	REN = AGND	1.14	1.24	1.34	V
Output-Voltage Temperature Drift	TCVREF			±50		ppm/°C
Reference Output Drive Capability				50		μA
Reference Input Voltage Range		REN = AVDD	0.1		1.32	V
Reference Supply Rejection				0.2		mV/V
Current Gain	IFS/IREF			32		mA/mA
INTERPOLATION FILTER (2x interpolation)						
Passband Width	fOUT/ 0.5fDAC	-0.005dB		0.398		MHz/ MHz
		-0.01dB		0.402		
		-0.1dB		0.419		
		-3dB		0.478		
Stopband Rejection		0.604fDAC / 2 to 1.396fDAC / 2		74		dB
		0.600fDAC / 2 to 1.400fDAC / 2		62		
		0.594fDAC / 2 to 1.406fDAC / 2		53		
		0.532fDAC / 2 to 1.468fDAC / 2		14		
Group Delay				18		Data clock cycles
Impulse Response Duration				22		Data clock cycles

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

ELECTRICAL CHARACTERISTICS (continued)

(AVDD = DVDD = PVDD = 3V, AGND = DGND = PGND = 0, fDAC = 165Msps, no interpolation, PLL disabled, external reference, VREF0 = 1.2V, IFS = 20mA, output amplitude = 0dB FS, differential output, TA = TMIN to TMAX, unless otherwise noted. TA > +25°C, guaranteed by production test. TA < +25°C, guaranteed by design and characterization. Typical values are at TA = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
INTERPOLATION FILTER (4x interpolation)						
Passband Width	fOUT/ 0.5fDAC	-0.005dB		0.2		MHz/ MHz
		-0.01dB		0.201		
		-0.1dB		0.21		
		-3dB		0.239		
Stopband Rejection		0.302fDAC / 2 to 1.698fDAC / 2		74		dB
		0.300fDAC / 2 to 1.700fDAC / 2		63		
		0.297fDAC / 2 to 1.703 fDAC / 2		53		
		0.266fDAC / 2 to 1.734fDAC / 2		14		
Group Delay				22		Data clock cycles
Impulse Response Duration				27		Data clock cycles
LOGIC INPUTS (IDE, $\overline{CW}$, $\overline{REN}$, DA7–DA0, DB7–DB0, PLEN)						
Digital Input Voltage High	VIH		2			V
Digital Input Voltage Low	VIL			0.8		V
Digital Input Current High	IH	VIH = 2V	-1		+1	μA
Digital Input Current Low	IIL	VIL = 0.8V	-1		+1	μA
Digital Input Capacitance	CIN			3		pF
DIGITAL OUTPUTS (CLK, LOCK)						
Digital Output-Voltage High	VOH	ISOURCE = 0.5mA, Figure 1		0.9 × DVDD		V
Digital Output-Voltage Low	VOL	ISINK = 0.5mA, Figure 1			0.1 × DVDD	V
DIFFERENTIAL CLOCK INPUT (CLKXP, CLKXN)						
Clock Input Internal Bias				PVDD/2		V
Differential Clock Input Swing			0.5			Vp-p
Clock Input Impedance		Single-ended clock drive		5		kΩ
TIMING CHARACTERISTICS						
Input Data Rate	fDATA	No interpolation			165	Msps
		2x interpolation	PLL disabled		150	
			PLL enabled		75	
		4x interpolation	PLL disabled		75	
			PLL enabled		37.5	

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

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ELECTRICAL CHARACTERISTICS (continued)

(AVDD = DVDD = PVDD = 3V, AGND = DGND = PGND = 0, fDAC = 165Msps, no interpolation, PLL disabled, external reference, VREFO = 1.2V, IFS = 20mA, output amplitude = 0dB FS, differential output, TA = TMIN to TMAX, unless otherwise noted. TA > +25°C, guaranteed by production test. TA < +25°C, guaranteed by design and characterization. Typical values are at TA = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Clock Frequency at CLK Input	fCLK	No interpolation, PLL enabled			165	MHz
		2x interpolation, PLL enabled	75		150	
		4x interpolation, PLL enabled	37.5		75	
Output Settling Time	ts	To ±0.1% error band (Note 2)		11		ns
Output Rise Time		10% to 90% (Note 2)		2.5		ns
Output Fall Time		90% to 10% (Note 2)		2.5		ns
Data-to-CLK Rise Setup Time (Note 3)	tDCSR	PLL disabled	1.5			ns
		PLL enabled	2.2			
Data-to-CLK Rise Hold Time (Note 3)	tDCHR	PLL disabled	0.4			ns
		PLL enabled	1.4			
Data-to-CLK Fall Setup Time (Note 3)	tDCSF	PLL disabled	1.8			ns
		PLL enabled	2.4			
Data-to-CLK Fall Hold Time (Note 3)	tDCHF	PLL disabled	1.2			ns
		PLL enabled	1.3			
Control Word to $\overline{CW}$ Fall Setup Time	tCWS		2.5			ns
Control Word to $\overline{CW}$ Fall Hold Time	tCWH		2.5			ns
$\overline{CW}$ High Time			5			ns
$\overline{CW}$ Low Time			5			ns
DACEN Rise-to-VOUT Stable	tSTB			0.7		μs
PD Fall-to-VOUT Stable	tPDSTB	External reference		0.5		ms
Clock Frequency at CLKXP/CLKXN Input	fCLKDIFF	Differential clock, PLL disabled			300	MHz
CLKXP/CLKXN Differential Clock Input to CLK Output Delay	tcXD	PLL disabled		4.6		ns
Minimum CLKXP/CLKXN Clock High Time	tcXH			1.5		ns
Minimum CLKXP/CLKXN Clock Low Time	tcXL			1.5		ns
POWER REQUIREMENTS						
Analog Power-Supply Voltage	AVDD		2.7		3.3	V
Analog Supply Current	IAVDD	(Note 4)		44	47	mA
Digital Power-Supply Voltage	DVDD		2.7		3.3	V

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

ELECTRICAL CHARACTERISTICS (continued)

(AVDD = DVDD = PVDD = 3V, AGND = DGND = PGND = 0, fDAC = 165Msps, no interpolation, PLL disabled, external reference, VREF0 = 1.2V, IFS = 20mA, output amplitude = 0dB FS, differential output, TA = TMIN to TMAX, unless otherwise noted. TA > +25°C, guaranteed by production test. TA < +25°C, guaranteed by design and characterization. Typical values are at TA = +25°C.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Digital Supply Current (Note 4)	IDVDD	fDAC = 60Msps	No interpolation		43		mA
			2x interpolation		99		
			4x interpolation		104		
		fDAC = 165Msps	No interpolation		53	58	
			2x interpolation		147		
			4x interpolation		147		
		fDAC = 200Msps	2x interpolation		165	178	
			4x interpolation		162	175	
PLL Power-Supply Voltage	PVDD			2.7		3.3	V
PLL Supply Current (Note 4)	IPVDD	fDAC = 60Msps			16		mA
		fDAC = 165Msps			47	50	
		fDAC = 200Msps, 2x interpolation or 4x interpolation			55	60	
Standby Current	ISTANDBY	(Note 5)			4.4	4.8	mA
Power-Down Current	IPD	(Note 5)			1		μA
Total Power Dissipation (Note 4)	PTOT	fDAC = 60Msps	No interpolation		309		mW
			2x interpolation		477		
			4x interpolation		492		
		fDAC = 165Msps	No interpolation		432	456	
			2x interpolation		714		
			4x interpolation		714		
		fDAC = 200Msps	2x interpolation		792		
			4x interpolation		783		

Note 1: Including the internal reference voltage tolerance.

Note 2: Measured single ended with 50Ω load and complementary output connected to ground.

Note 3: Guaranteed by design, not production tested.

Note 4: Tested with an output frequency of fOUT = 5MHz.

Note 5: All digital inputs at 0 or DVDD. Clock signal disabled.

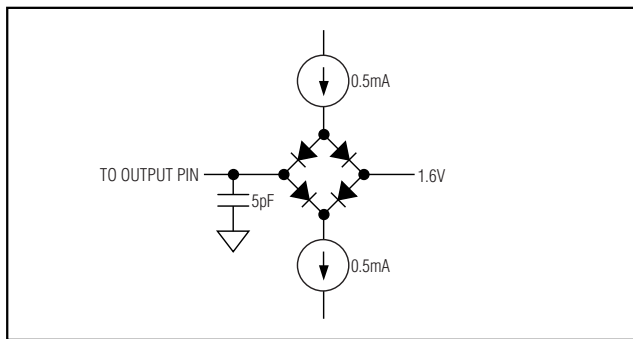


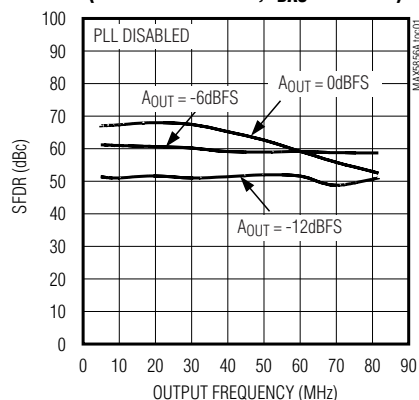
Figure 1. Load Test Circuit for CLK Outputs

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

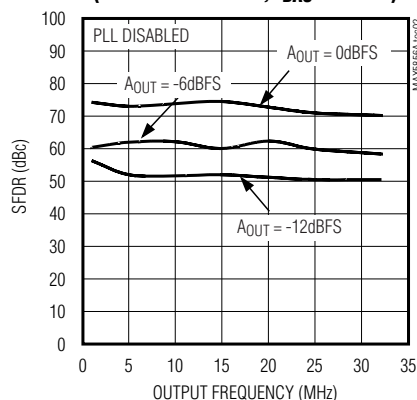
Typical Operating Characteristics

($AV_{DD} = DV_{DD} = PV_{DD} = 3V$, $AGND = DGND = PGND = 0$, external reference = 1.2V, no interpolation, PLL disabled, $I_{FS} = 20mA$, differential output, $T_A = +25^{\circ}C$, unless otherwise noted.)

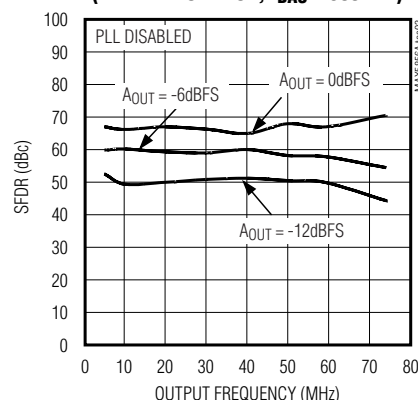
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(NO INTERPOLATION, $f_{DAC} = 165MHz$)**



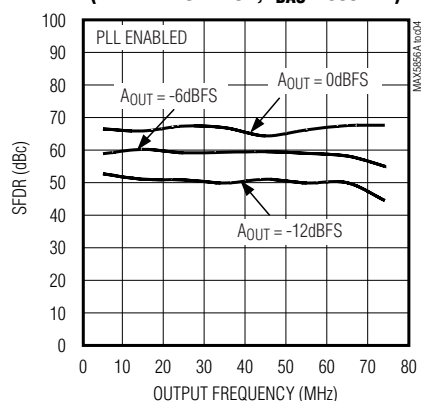
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(NO INTERPOLATION, $f_{DAC} = 65MHz$)**



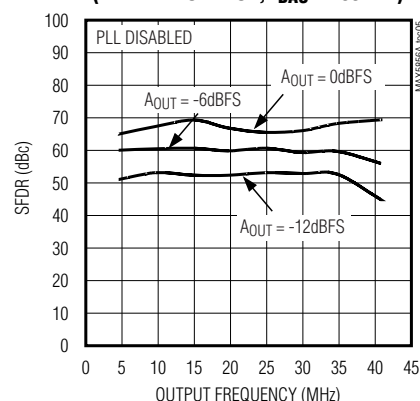
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(2x INTERPOLATION, $f_{DAC} = 300MHz$)**



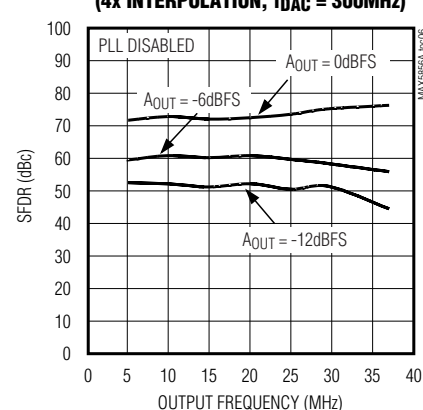
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(2x INTERPOLATION, $f_{DAC} = 300MHz$)**



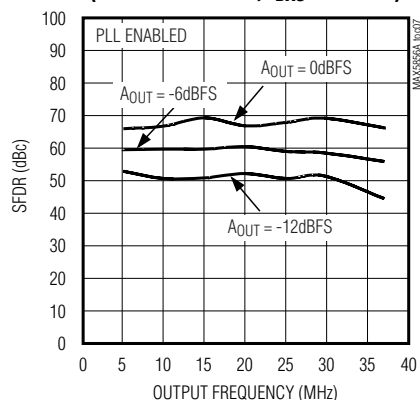
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(2x INTERPOLATION, $f_{DAC} = 165MHz$)**



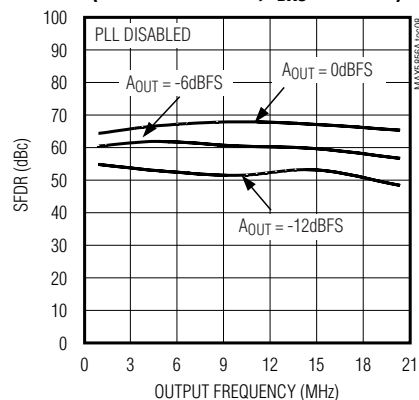
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(4x INTERPOLATION, $f_{DAC} = 300MHz$)**



**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(4x INTERPOLATION, $f_{DAC} = 300MHz$)**



**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(4x INTERPOLATION, $f_{DAC} = 165MHz$)**

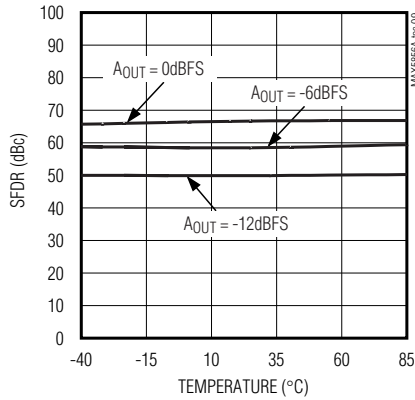


Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

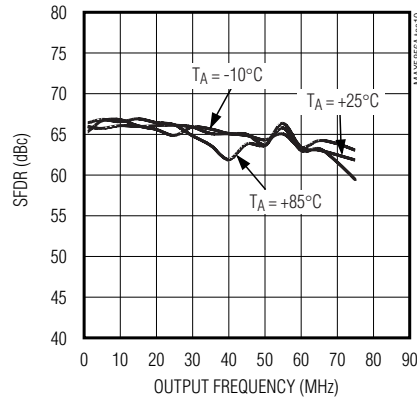
Typical Operating Characteristics (continued)

($AV_{DD} = DV_{DD} = PV_{DD} = 3V$, $AGND = DGND = PGND = 0$, external reference = 1.2V, no interpolation, PLL disabled, $I_{FS} = 20mA$, differential output, $T_A = +25^\circ C$, unless otherwise noted.)

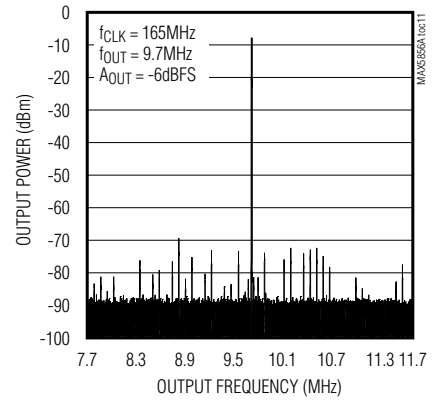
**SPURIOUS-FREE DYNAMIC RANGE
vs. TEMPERATURE (NO INTERPOLATION,
 $f_{DAC} = 165MHz$, $f_{OUT} = 5MHz$)**



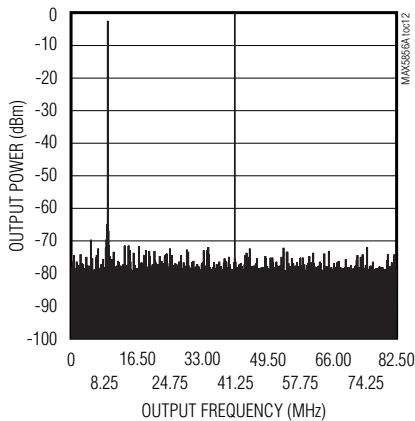
**SPURIOUS-FREE DYNAMIC RANGE
vs. OUTPUT FREQUENCY
(NO INTERPOLATION, $f_{DAC} = 165MHz$)**



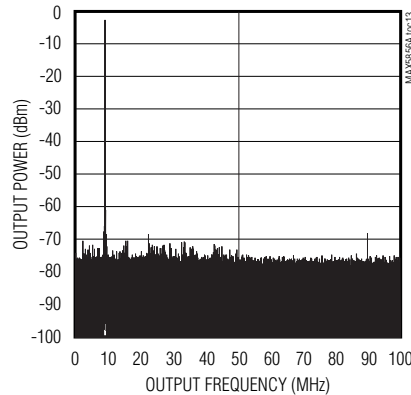
FFT PLOT ($\pm 2MHz$ WINDOW)



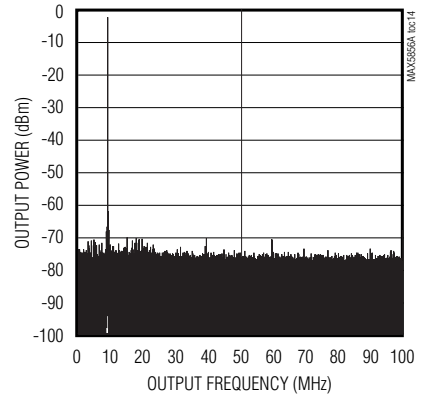
**FFT PLOT FOR DAC UPDATE NYQUIST WINDOW
(NO INTERPOLATION, $f_{DAC} = 165MHz$,
 $f_{OUT} = 10MHz$, $A_{OUT} = 0dBFS$)**



**FFT PLOT FOR DAC UPDATE NYQUIST WINDOW (2x INTERPOLATION,
 $f_{DAC} = 200MHz$, $f_{OUT} = 10MHz$, $A_{OUT} = 0dBFS$)**



**FFT PLOT FOR DAC UPDATE NYQUIST WINDOW (4x INTERPOLATION,
 $f_{DAC} = 200MHz$, $f_{OUT} = 10MHz$, $A_{OUT} = 0dBFS$)**

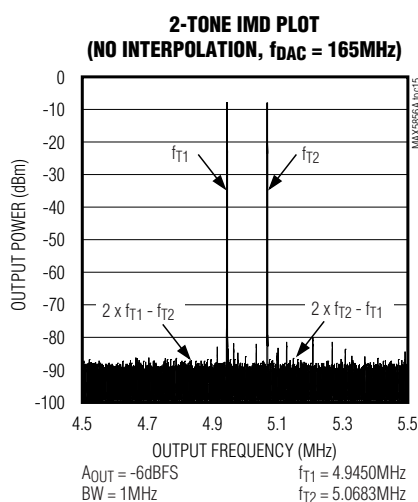
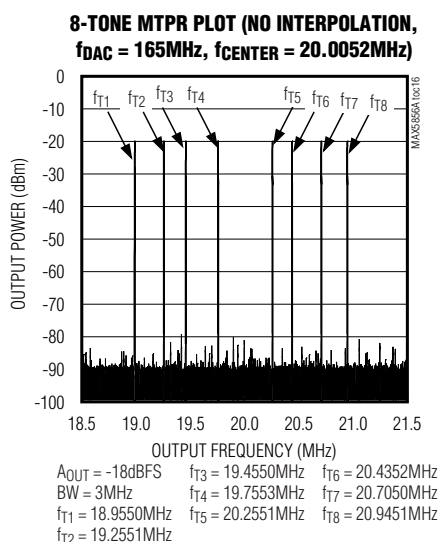
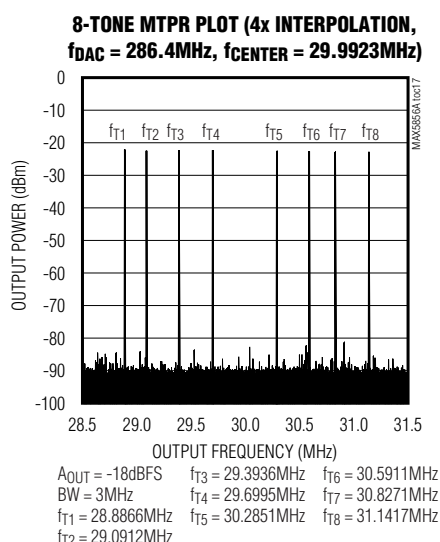
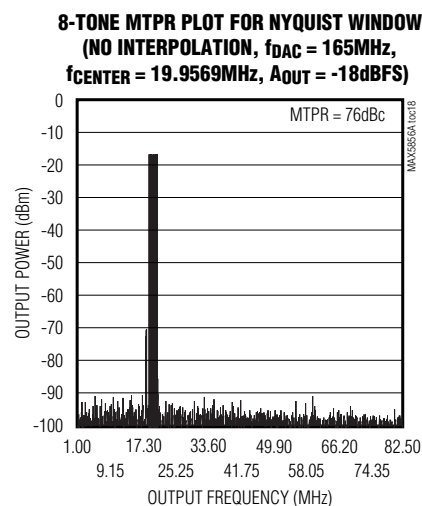
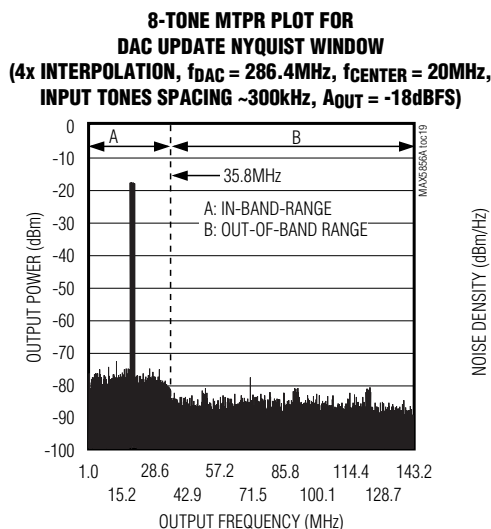
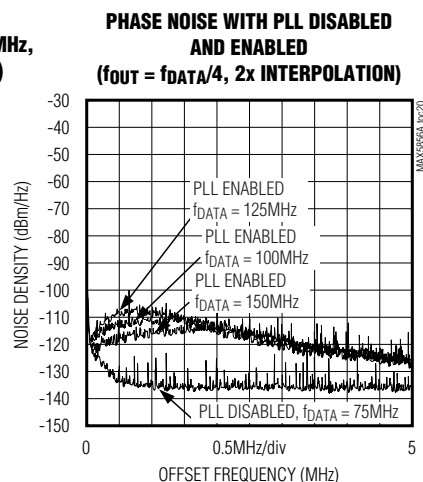


Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

MAX5856A

Typical Operating Characteristics (continued)

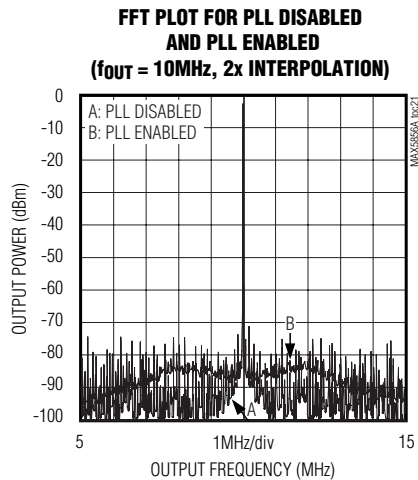
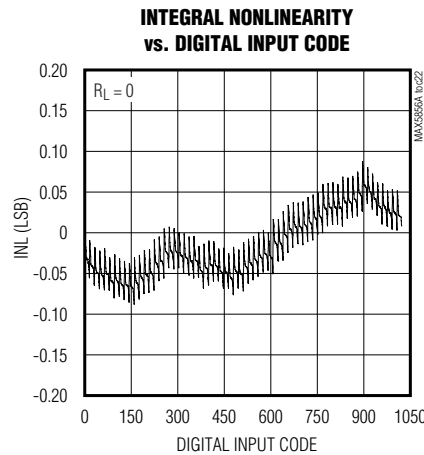
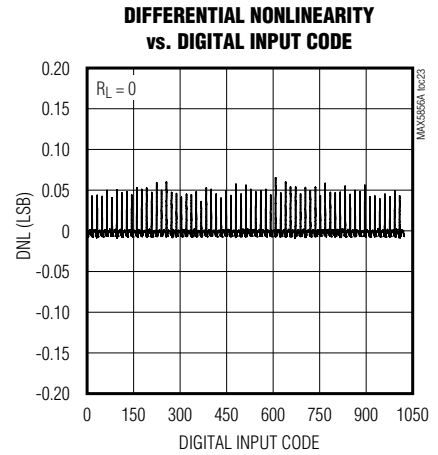
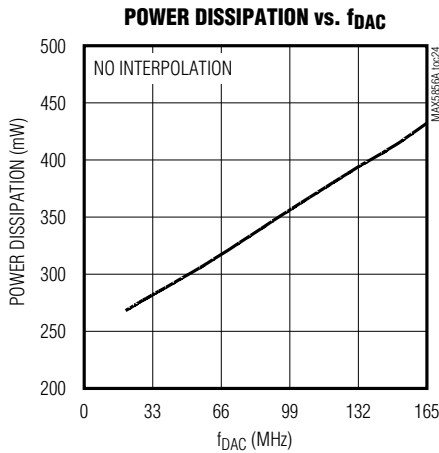
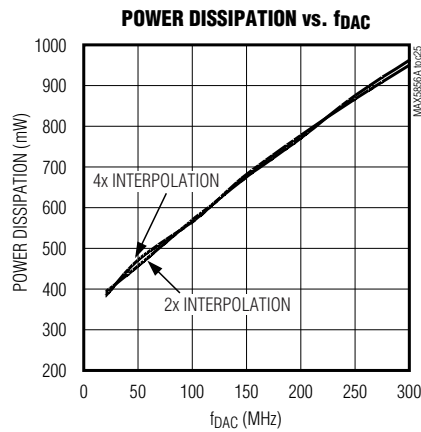
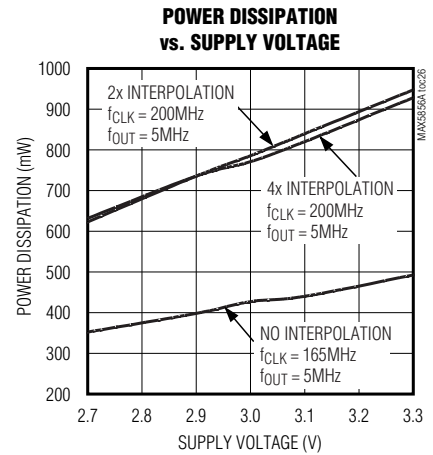
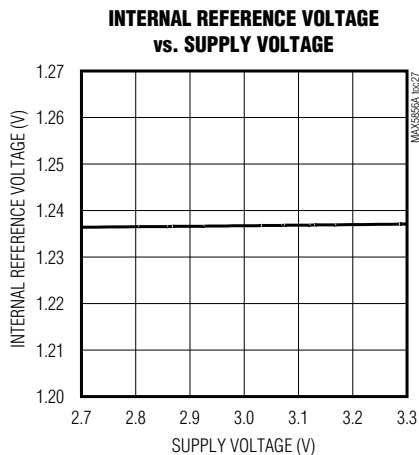
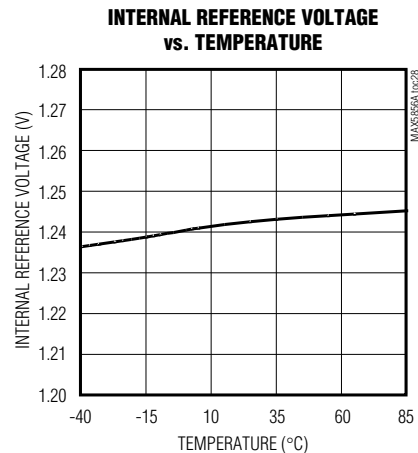
($AV_{DD} = DV_{DD} = PV_{DD} = 3V$, $AGND = DGND = PGND = 0$, external reference = 1.2V, no interpolation, PLL disabled, $I_{FS} = 20mA$, differential output, $T_A = +25^\circ C$, unless otherwise noted.)



Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Typical Operating Characteristics (continued)

($AV_{DD} = DV_{DD} = PV_{DD} = 3V$, $AGND = DGND = PGND = 0$, external reference = 1.2V, no interpolation, PLL disabled, $I_{FS} = 20mA$, differential output, $T_A = +25^\circ C$, unless otherwise noted.)

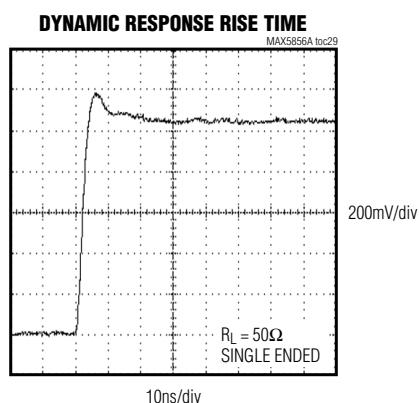
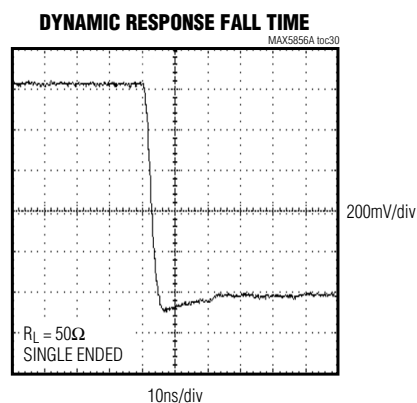


Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

MAX5856A

Typical Operating Characteristics (continued)

($AV_{DD} = DV_{DD} = PV_{DD} = 3V$, $AGND = DGND = PGND = 0$, external reference = 1.2V, no interpolation, PLL disabled, $I_{FS} = 20mA$, differential output, $T_A = +25^{\circ}C$, unless otherwise noted.)



Pin Description

PIN	NAME	FUNCTION
1	DA7/PD	Channel A Input Data Bit 7 (MSB)/Power-Down Control Bit: 0: Enter DAC standby mode ($DACEN = 0$) or power up DAC ($DACEN = 1$). 1: Enter power-down mode.
2	DA6/DACEN	Channel A Input Data Bit 6/DAC Enable Control Bit: 0: Enter DAC standby mode with $PD = 0$. 1: Power up DAC with $PD = 0$. X: Enter power-down mode with $PD = 1$ (X = don't care).
3	DA5/F2EN	Channel A Input Data Bit 5/Second Interpolation Filter Enable Bit: 0: Interpolation mode is determined by F1EN. 1: Enable 4x interpolation mode. (F1EN must equal 1.)
4	DA4/F1EN	Channel A Input Data Bit 4/First Interpolation Filter Enable Bit: 0: Interpolation disable. 1: Enable 2x interpolation.
5	DA3/G3	Channel A Input Data Bit 3/Channel A Gain Adjustment Bit 3
6, 19, 47	DGND	Digital Ground
7, 18, 48	DVDD	Digital Power Supply. See <i>Power Supplies, Bypassing, Decoupling, and Layout</i> section.
8	DA2/G2	Channel A Input Data Bit 2/Channel A Gain Adjustment Bit 2
9	DA1/G1	Channel A Input Data Bit 1/Channel A Gain Adjustment Bit 1
10	DA0/G0	Channel A Input Data Bit 0/Channel A Gain Adjustment Bit 0
11, 12, 25, 26, 37, 38	N.C.	No Connection. Not connected internally.
13	DB7	Channel B Input Data Bit 7 (MSB)
14	DB6	Channel B Input Data Bit 6

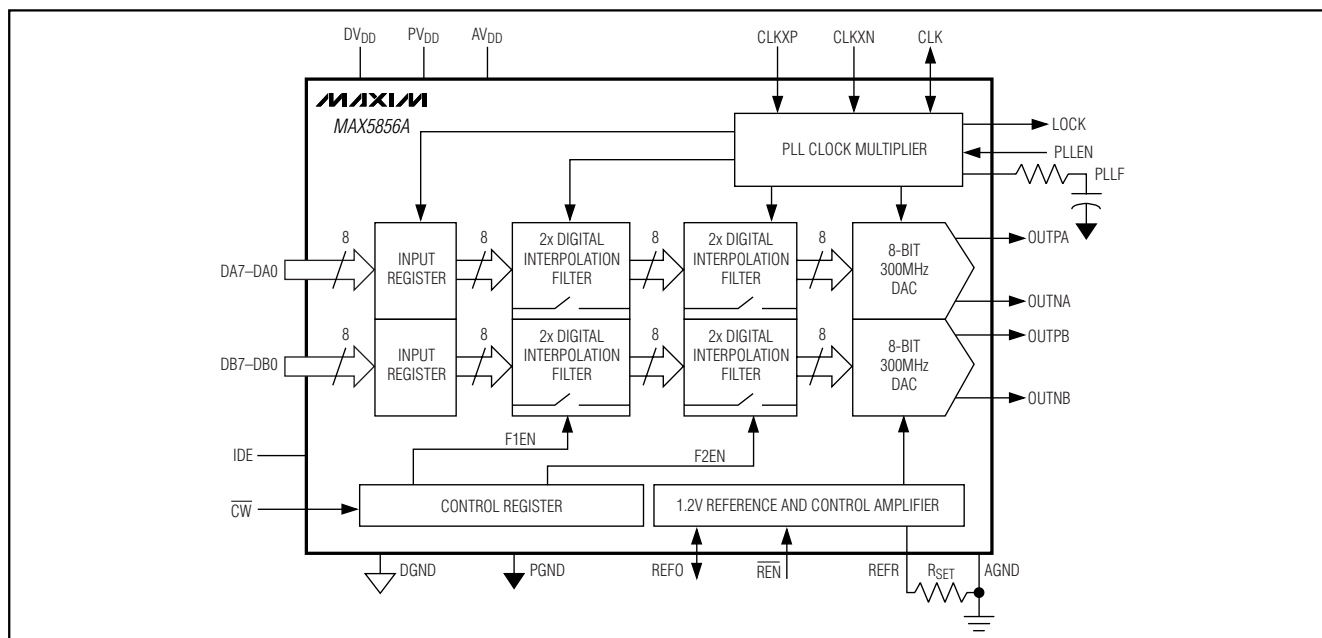
Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Pin Description (continued)

PIN	NAME	FUNCTION
15	DB5	Channel B Input Data Bit 5
16	DB4	Channel B Input Data Bit 4
17	DB3	Channel B Input Data Bit 3
20	CLK	Clock Output/Input. CLK becomes an input when the PLL is enabled. CLK is an output when the PLL is disabled.
21	IDE	Interleave Data Mode Enable. When IDE is high, data for both DAC channels is written through port A (bits DA7–DA0). When IDE is low, channel A data is latched on the rising edge of CLK and channel B is latched on the falling edge of CLK.
22	DB2	Channel B Input Data Bit 2
23	DB1	Channel B Input Data Bit 1
24	DB0	Channel B Input Data Bit 0
27	$\overline{CW}$	Active-Low Control Word Write Pulse. The control word is latched on the falling edge of $\overline{CW}$.
28	LOCK	PLL Lock Signal Output. High level indicates that PLL is locked to the CLK signal.
29	PLLEN	PLL Enabled Input. PLL is enabled when PLLEN is high.
30	CLKXP	Differential Clock Input Positive Terminal. Connect to PGND when the PLL is enabled. Bypass CLKXP with a 0.01 μ F capacitor to PGND when CLKXN is in single-ended mode.
31	CLKXN	Differential Clock Input Negative Terminal. Connect to PVDD when the PLL is enabled. Bypass CLKXN with a 0.01 μ F capacitor to PGND when CLKXP is in single-ended mode.
32	PVDD	PLL Power Supply. See <i>Power Supplies, Bypassing, Decoupling, and Layout</i> section.
33	PGND	PLL Ground
34	PLLF	PLL Loop Filter. Connect a 4.12k Ω resistor in series with a 100pF capacitor between PLLF and PGND.
35	$\overline{REN}$	Active-Low Reference Enable. Connect $\overline{REN}$ to AGND to activate the on-chip 1.24V reference.
36	REFO	Reference I/O. REFO serves as the reference input when the internal reference is disabled. If the internal 1.24V reference is enabled, REFO serves as the output for the internal reference. When the internal reference is enabled, bypass REFO to AGND with a 0.1 μ F capacitor.
39	REFR	Full-Scale Current Adjustment. To set the output full-scale current, connect an external resistor R_{SET} between REFR and AGND. The output full-scale current is equal to $32 \times V_{REFO} / R_{SET}$.
40, 46	AVDD	Analog Power Supply. See <i>Power Supplies Bypassing, Decoupling, and Layout</i> section.

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Functional Diagram



MAX5856A

Detailed Description

The MAX5856A dual, high-speed, 8-bit, current-output DAC provides superior performance in communication systems requiring low-distortion analog-signal reconstruction. The MAX5856A combines two DAC cores with 4x/2x/1x programmable digital interpolation filters, a PLL clock multiplier, divide-by-N clock output, and an on-chip 1.24V reference. The DAC current outputs can be configured for differential or single-ended operation. The full-scale output current range is adjustable from 2mA to 20mA to optimize power dissipation and gain control.

The MAX5856A accepts an input data rate up to 165MHz or a DAC conversion rate up to 300MHz. The inputs are latched on the rising edge of the clock. The outputs are latched on the following rising edge.

The two-stage digital interpolation filters are programmable to 4x, 2x, or no interpolation. When operating in 4x interpolation mode, the interpolator increases the DAC conversion rate by a factor of four, providing a four-fold increase in separation between the reconstructed waveform spectrum and its first image.

The on-chip PLL clock multiplier generates and distributes all internal, synchronized high-speed clock signals required by the input data latches, interpolation filters, and DAC cores. The on-chip PLL includes phase detector, VCO, prescaler, and charge pump circuits. The PLL can be enabled or disabled through PLLEN.

The analog and digital sections of the MAX5856A have separate power supply inputs (AVDD and DVDD). Also, a separate supply input is provided for the PLL clock multiplier (PVDD). AVDD, DVDD, and PVDD operate from a 2.7V to 3.3V single supply.

The MAX5856A features three power modes: normal, standby, and power-down. These modes allow efficient power management. In power-down, the MAX5856A consumes only 1μA of supply current. Wake-up time from standby mode to normal DAC operation is 0.7μs.

Programming the DAC

An 8-bit control word routed through channel A's data port programs the gain matching, interpolator configuration, and operational mode of the MAX5856A. The control word is latched on the falling edge of control-word write pulse (CW). The CW signal is asynchronous with CLK and CLKXN/CLKXP; therefore, the conversion clock (CLK or CLKXN/CLKXP) can run uninterrupted when a control word is written to the device.

Table 1 illustrates the control word format and function.

The gain on channel A can be adjusted to achieve gain matching between two channels in a user's system. The gain on channel A can be adjusted from +0.4dB to -0.35dB in steps of 0.05dB by using bits G3 to G0 (see Table 3).

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Device Power-Up and States of Operation

At power-up, the MAX5856A is configured in no-interpolation mode with a gain adjustment setting of 0dB and a fully operational converter. In shutdown, the MAX5856A consumes only 1μA of supply current, and in standby the current consumption is 4.4mA. Wake-up time from standby mode to normal operation is 0.7μs.

Interpolation Filters

The MAX5856A features a 2-stage, 2x digital interpolating filter based on 43-tap and 23-tap FIR topology. F1EN and F2EN enable the interpolation filters. F1EN = 1 enables the first filter for 2x interpolation and F2EN = 1 enables the second filter for combined 4x interpolation. To bypass and disable both interpolation filters (no-interpolation mode or 1x mode) set F1EN = F2EN = 0. When set for 1x mode the filters are powered down and consume virtually no current. An illegal condition is defined by: F1EN = 0, F2EN = 1 (see Table 2 for configuration modes).

The programmable interpolation filters multiply the MAX5856A input data rate by a factor of two or four to separate the reconstructed waveform spectrum and the first image. The original spectral images, appearing around multiples of the DAC input data rate, are attenuated at least 60dB by the internal digital filters. This feature provides three benefits:

- 1) Image separation reduces complexity of analog reconstruction filters.
- 2) Lower input data rates eliminate board-level high-speed data transmission.
- 3) $\text{Sin}(x)/x$ rolloff is reduced over the effective bandwidth.

Figure 2 shows an application circuit and Figure 3 illustrates a practical example of the benefits when using the MAX5856A with 4x-interpolation mode. The example illustrates signal synthesis of a 20MHz IF with a $\pm 10\text{MHz}$ bandwidth. Three options can be considered to address the design requirements. The tradeoffs for each solution are shown in Table 4.

Table 1. Control Word Format and Function

MSB				LSB			
PD	DACEN	F2EN	F1EN	G3	G2	G1	G0
CONTROL WORD	FUNCTION						
PD	Power-down; The part enters power-down mode if PD = 1.						
DACEN	DAC Enable; When DACEN = 0 and PD = 0, the part enters standby mode.						
F2EN	Filter Enable; When F2EN = 1 and F1EN = 1, 4x interpolation is enabled. When F2EN = 0, the interpolation mode is determined by F1EN.						
F1EN	Filter Enable; When F1EN = 1 and F2EN = 0, 2x interpolation is active. With F1EN = 0 and F2EN = 0, the interpolation is disabled.						
G3	Bit 3 (MSB) of gain adjust word.						
G2	Bit 2 of gain adjust word.						
G1	Bit 1 of gain adjust word.						
G0	Bit 0 (LSB) of gain adjust word.						

Table 2. Configuration Modes

MODE	PD	DACEN	F2EN	F1EN
No interpolation	0	1	0	0
2x interpolation	0	1	0	1
4x interpolation	0	1	1	1
Standby	0	0	X	X
Power-down	1	X	X	X
Power-up	0	1	X	X

X = Don't care.

F1EN = 0, F2EN = 1: illegal condition.

Table 3. Gain Difference Setting

GAIN ADJUSTMENT ON CHANNEL A (dB)	G3	G2	G1	G0
+0.4	0	0	0	0
0	1	0	0	0
-0.35	1	1	1	1

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

MAX5856A

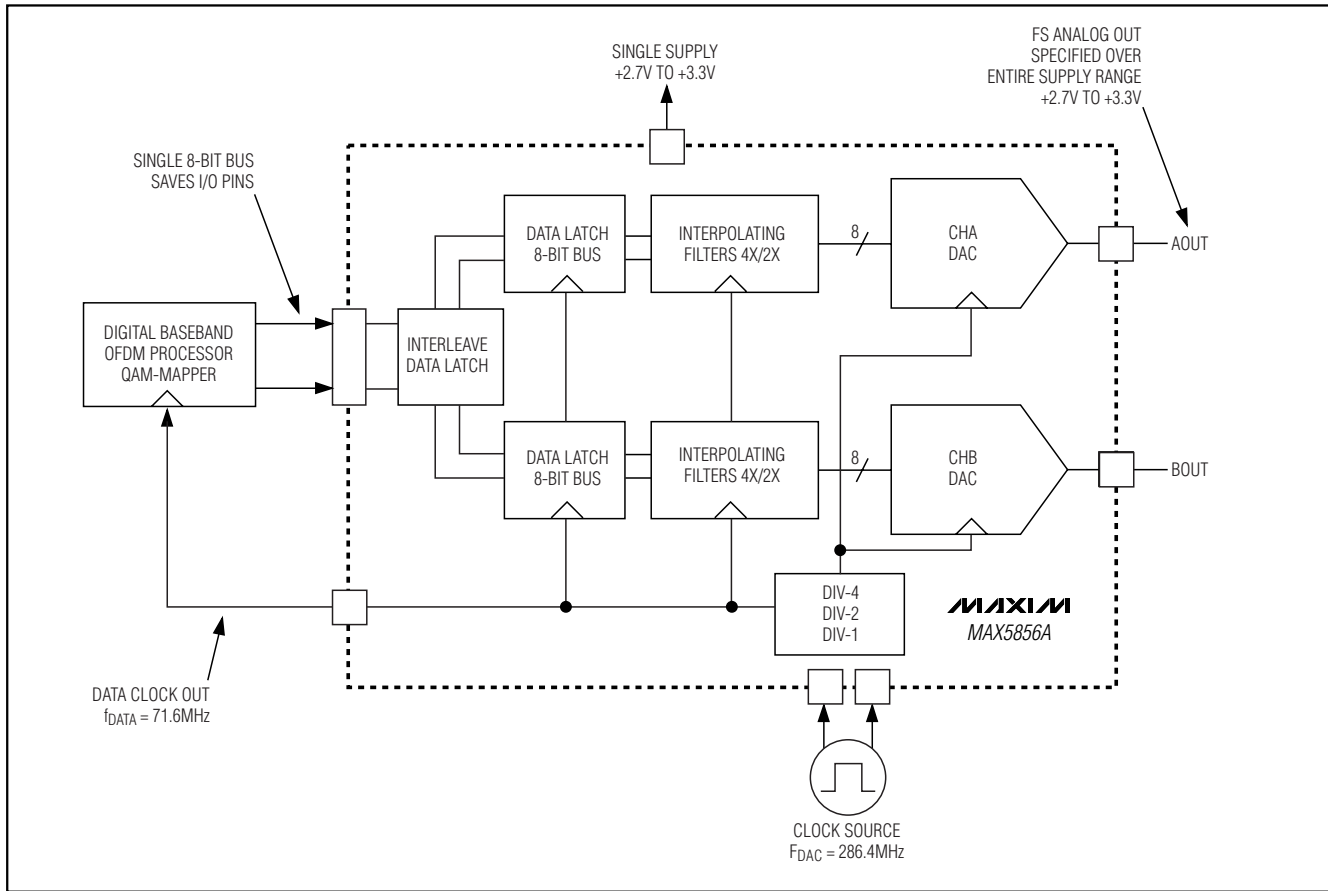


Figure 2. Typical Application Circuit

Table 4. Benefits of Interpolation

OPTION	SOLUTION	ADVANTAGE	DISADVANTAGE
1	<ul style="list-style-type: none"> No interpolation 2.6x oversample $f_{DAC} = f_{DATA} = 78\text{MHz}$ 	<ul style="list-style-type: none"> Low data rate Low clock rate 	<ul style="list-style-type: none"> High-order filter Filter gain/phase match
2	<ul style="list-style-type: none"> No interpolation 8x oversample $f_{DAC} = f_{DATA} = 240\text{MHz}$ Push image to $f_{IMAGE} = 210\text{MHz}$ 	<ul style="list-style-type: none"> Lower order filter Filter gain/phase match 	<ul style="list-style-type: none"> High clock rate High data rate
3	<ul style="list-style-type: none"> 4x interpolation $f_{DAC} = 286.4\text{MHz}$, $f_{DATA} = 71.6\text{MHz}$ Passband attenuation = 0.1dB Push image to 256MHz 	<ul style="list-style-type: none"> Low data rate Low-order filter 60dB image attenuate Filter gain/phase match 	<ul style="list-style-type: none"> None

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

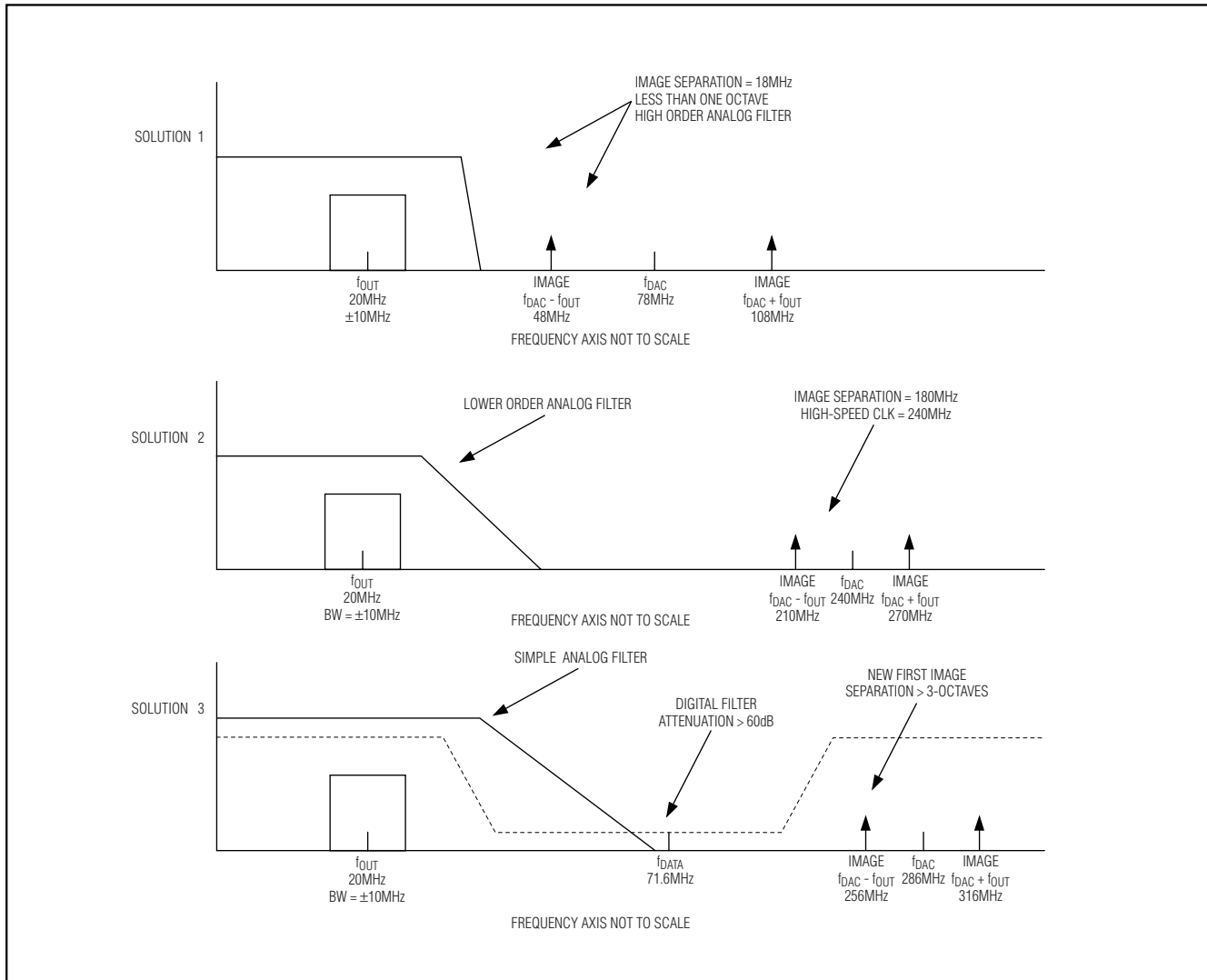


Figure 3. MAX5856A in 4x Interpolation Mode

This example demonstrates that 4x interpolation with digital filtering yields significant benefits in reducing system complexity, improving dynamic performance, and lowering cost. Data can be written to the MAX5856A at much lower speeds while achieving image attenuation greater than 60dB and image separation beyond three octaves. The main benefit is in analog reconstruction fil-

ter design. Reducing the filter order eases gain/phase matching while lowering filter cost and saving board space. Because the data rate is lowered to 71.6MHz, the setup and hold times are manageable and the clock signal source is simplified, which results in improved system reliability and lower cost.

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

PLL Clock Multiplier and Clocking Modes

The MAX5856A features an on-chip PLL clock multiplier, which generates all internal, synchronized high-speed clock signals required by the input data latches, interpolation filters, and DAC cores. The on-chip PLL includes a phase detector, VCO, prescaler, and charge-pump circuits. The PLL can be enabled or disabled through PLEN. To enable PLL, set PLEN = 1.

With the PLL enabled (PLEN = 1) and 4x/2x interpolation enabled, an external low-frequency clock reference source may be applied to CLK pin. The clock reference source serves as the input data clock. The on-chip PLL multiplies the clock reference by a factor of two (2x) or a factor of four (4x). The input data rate range and CLK frequency are set by the selected interpolation mode. In 2x interpolation mode, the data rate range is 75MHz to 150MHz. In 4x interpolation mode, the data rate range is 37.5MHz to 75MHz.

Note: When the PLL is enabled, CLK becomes an input, requiring CLKXP to be pulled low and CLKXN to be pulled high. To obtain the best phase noise performance, disable the PLL function.

With the PLL disabled (PLEN = 0) and 4x/2x interpolation enabled, an external conversion clock is applied at CLKXN/CLKXP. The conversion clock at CLKXN/CLKXP has a frequency range of 0 to 300MHz (see Table 5). This clock is buffered and distributed by the MAX5856A to drive the interpolation filters and DAC cores. In this mode, CLK becomes a divide-by-N (DIV-N) output at either a divide-by-two or divide-by-four rate. The DIV-N factor is set by the selected interpola-

tion mode. The CLK output, at DIV-N rate, must be used to synchronize data into the MAX5856A data ports. In this mode, keep the capacitive load at the CLK output low (10pF or less at $f_{DAC} = 165\text{MHz}$).

With the interpolation disabled (1x mode) and the PLL disabled (PLEN = 0), the input clock at CLKXN/CLKXP can be used to directly update the DAC cores. In this mode, the maximum data rate is 165MHz.

Internal Reference and Control Amplifier

The MAX5856A provides an integrated 50ppm/°C, 1.24V, low-noise bandgap reference that can be disabled and overridden with an external reference voltage. REFO serves either as an external reference input or an integrated reference output. If $\overline{\text{REN}}$ is connected to AGND, the internal reference is selected and REFO provides a 1.24V (50μA) output. Buffer REFO with an external amplifier, when driving a heavy load.

The MAX5856A also employs a control amplifier designed to simultaneously regulate the full-scale output current (IFS) for both outputs of the devices. Calculate the output current as:

$$I_{FS} = 32 \times I_{REF}$$

where I_{REF} is the reference output current ($I_{REF} = V_{REF}/R_{SET}$) and I_{FS} is the full-scale output current. R_{SET} is the reference resistor that determines the amplifier output current of the MAX5856A (Figure 4). This current is mirrored into the current-source array where I_{FS} is equally distributed between matched current segments and summed to valid output current readings for the DACs.

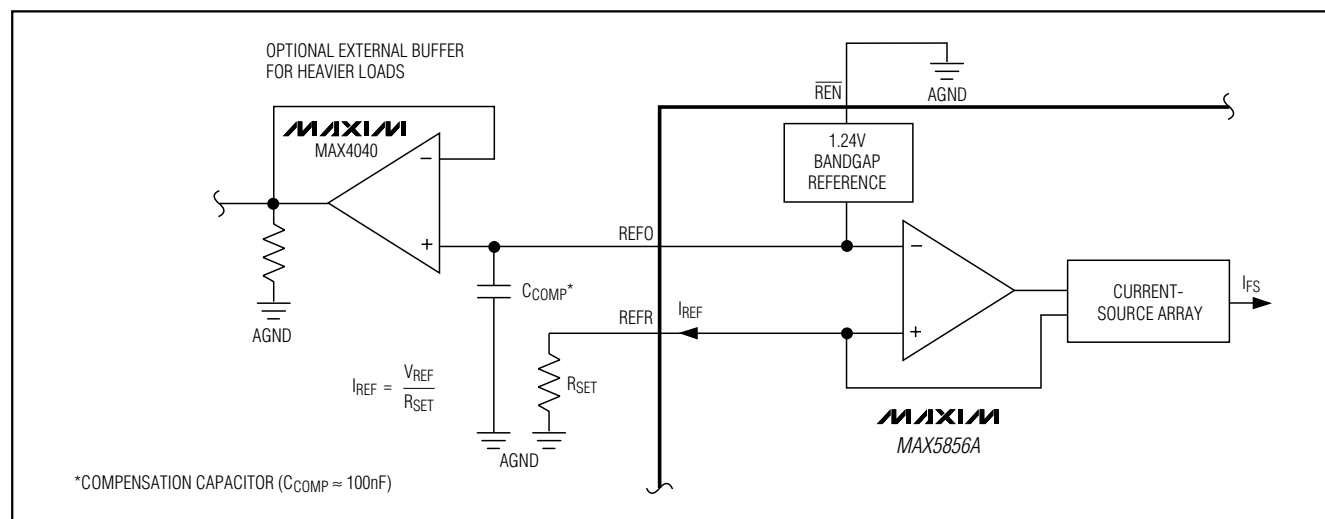


Figure 4. Setting IFS with the Internal 1.24V Reference and the Control Amplifier

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

External Reference

To disable the internal reference of the MAX5856A, connect REN to AVDD. Apply a temperature-stable, external reference to REFO to set the full-scale output (Figure 5). For improved accuracy and drift performance, choose a fixed output voltage reference such as the MAX6520 bandgap reference.

Detailed Timing

The MAX5856A accepts an input data rate up to 165MHz or a DAC conversion rate of up to 300MHz. The inputs are latched on the rising edge of the clock. The outputs are latched on the following rising edge.

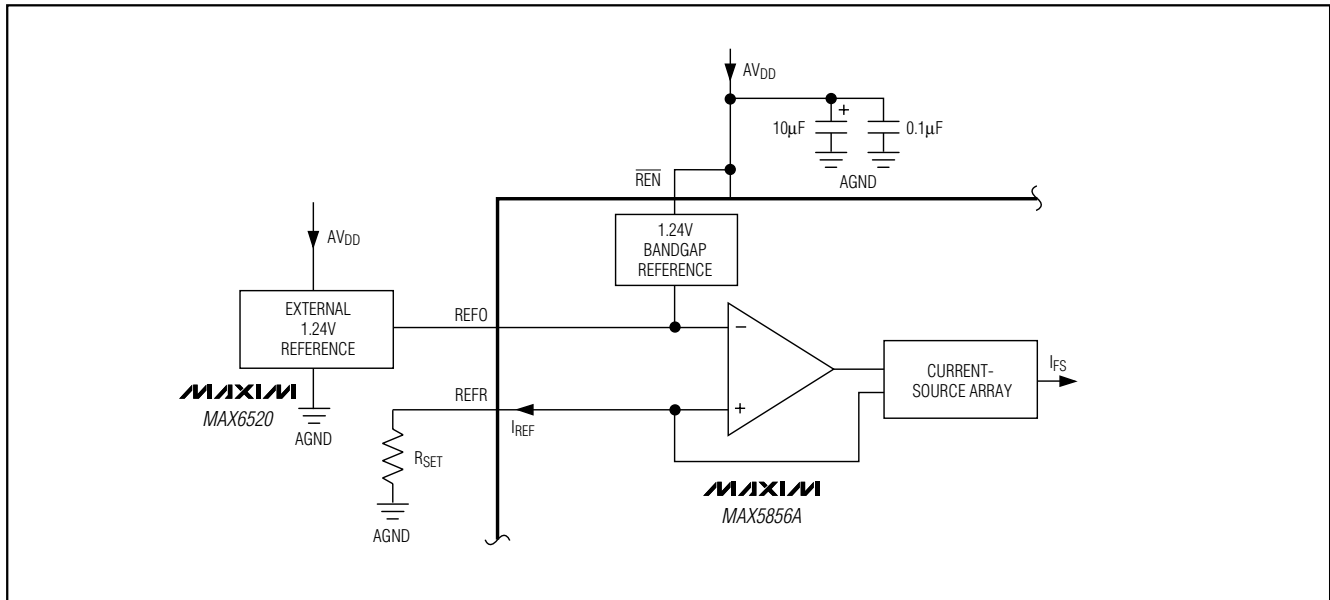


Figure 5. MAX5856A with External Reference

Table 5. PLL Clocking Modes

PLLEN	F2EN	F1EN	DIFFERENTIAL CLOCK FREQUENCY $f_{CLKDIFF}$ (MHz)	CLOCK FREQUENCY f_{CLK} (MHz)	DAC RATE f_{DAC}	INTERPOLATION	MAX SIGNAL BANDWIDTH (MHz)
1	0	0	N/A (tie CLXP low and CLXN high)	0 to 165 (input)	f_{CLK}	1x	82
1	0	1	N/A (tie CLXP low and CLXN high)	75 to 150 (input)	$2 * f_{CLK}$	2x	63
1	1	1	N/A (tie CLXP low and CLXN high)	37 to 75 (input)	$4 * f_{CLK}$	4x	31
0	0	0	0 to 165	$f_{CLKDIFF}$ (output)	$f_{CLKDIFF}$	1x	82
0	0	1	0 to 300	$f_{CLKDIFF} / 2$ (output)	$f_{CLKDIFF}$	2x	63
0	1	1	0 to 300	$f_{CLKDIFF} / 4$ (output)	$f_{CLKDIFF}$	4x	31
0	1	0	Illegal				
1	1	0					

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Figure 6 illustrates the DAC write cycle in 4x interpolation mode. With the interpolation feature enabled, the device can operate with the PLL enabled or disabled. To obtain best phase noise performance, disable the PLL and keep the capacitive load at the CLK output low (10pF or less at $f_{DAC} = 165\text{MHz}$).

With the PLL disabled ($PLLEN = 0$), the clock signal is applied to CLKXP/CLKXN and internally divided by 4 to generate the DAC's CLK signal. The CLK signal is a divide-by-4 output, used to synchronize data into the MAX5856A data ports. The CLKXP/CLKXN signal drives the interpolation filters and DAC cores at the desired conversion rate.

If the PLL is enabled ($PLLEN = 1$), then CLK becomes an input and the clock signal may be applied to CLK. In Figure 6, the CLK signal is multiplied by a factor of four by the PLL and distributed to the interpolation filters and DAC cores. In this mode, CLKXP must be pulled low and CLKXN pulled high.

The MAX5856A can operate with a single-ended clock input used as both data clock and conversion clock. To operate the device in this mode, disable the interpolation filters and enable the PLL ($PLLEN = 1$). Apply a single-ended clock input at CLK. The CLK signal acts as the data synchronization clock and DAC core conversion clock. Though the PLL is enabled, the lock pin (LOCK) is not valid and the PLL is internally disconnected from the interpolating filters and DAC cores. In this mode, CLKXP must be pulled low and CLKXN pulled high.

Figure 6 shows the timing for the $\overline{CW}$. An 8-bit control word routed through channel A's data port programs the gain matching, interpolator configuration, and operational mode of the MAX5856A. The control word is latched on the falling edge of $\overline{CW}$. The $\overline{CW}$ signal is asynchronous with conversion clocks CLK and CLKXN/CLKXP; therefore, the conversion clock (CLK or CLKXN/CLKXP) can run uninterrupted when a control word is written to the device.

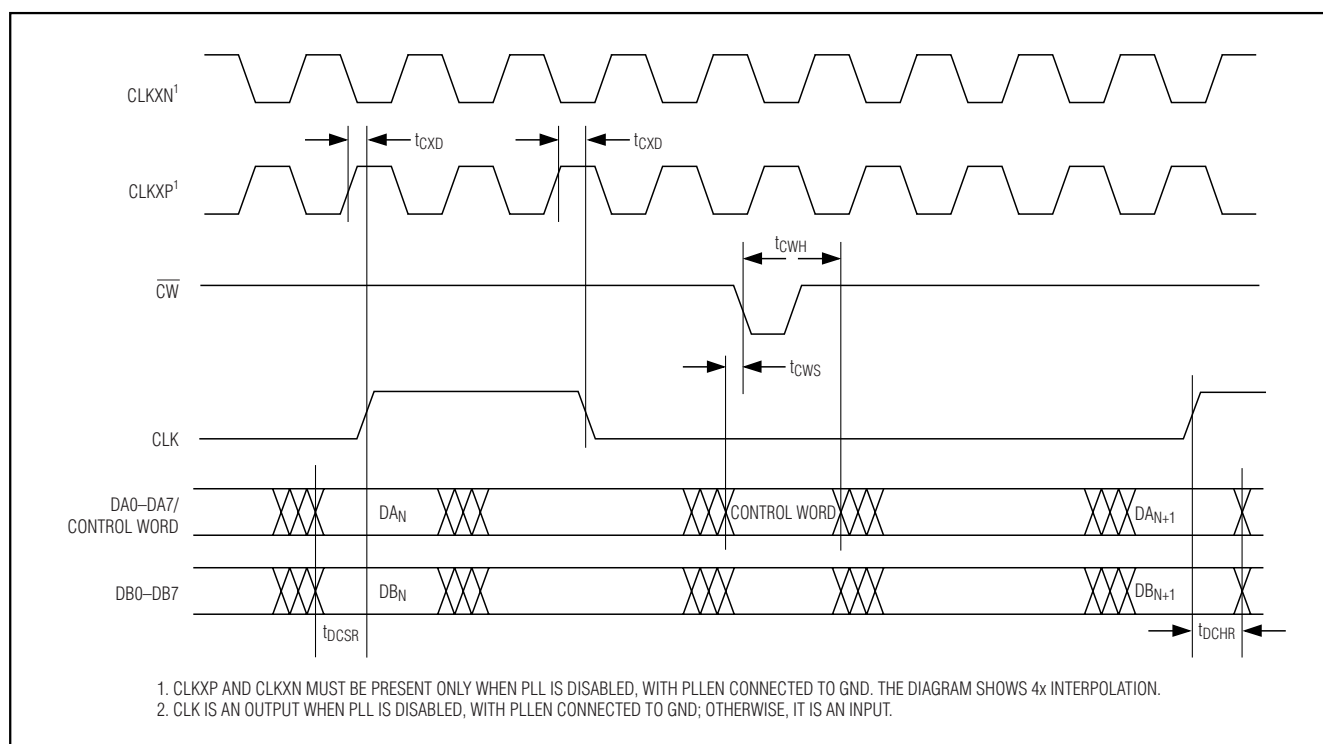


Figure 6. Timing Diagram for Noninterleave Data Mode ($IDE = \text{Low}$)

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

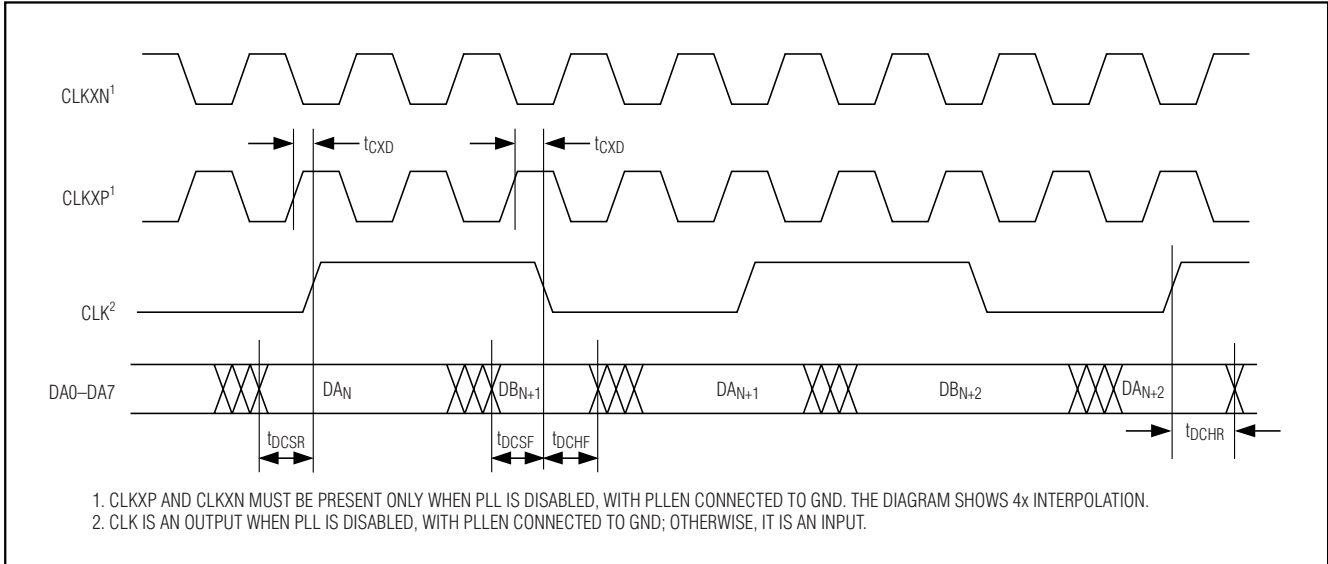


Figure 7. Timing Diagram for Interleave Data Mode (IDE = High)

The MAX5856A can operate in interleave data mode by setting IDE = 1. In interleave data mode, data for both DAC channels is written through input port A. Channel B data is written on the falling edge of the CLK signal and then channel A data is written on the following rising edge of the CLK signal. Both DAC outputs (channel A and B) are updated simultaneously on the next rising edge of CLK. In interleave data mode, the maximum input data rate per channel is one-half the rate of noninterleave mode. Interleave data mode is an attractive feature that lowers digital I/O pin count, reduces digital ASIC cost, and improves system reliability (Figure 7).

Applications Information

Differential-to-Single-Ended Conversion

The MAX5856A exhibits excellent dynamic performance to synthesize a wide variety of modulation schemes, including high-order QAM modulation with OFDM.

Figure 8 shows a typical application circuit with output transformers performing the required differential-to-single-ended signal conversion. In this configuration, the MAX5856A operates in differential mode, which reduces even-order harmonics, and increases the available output power.

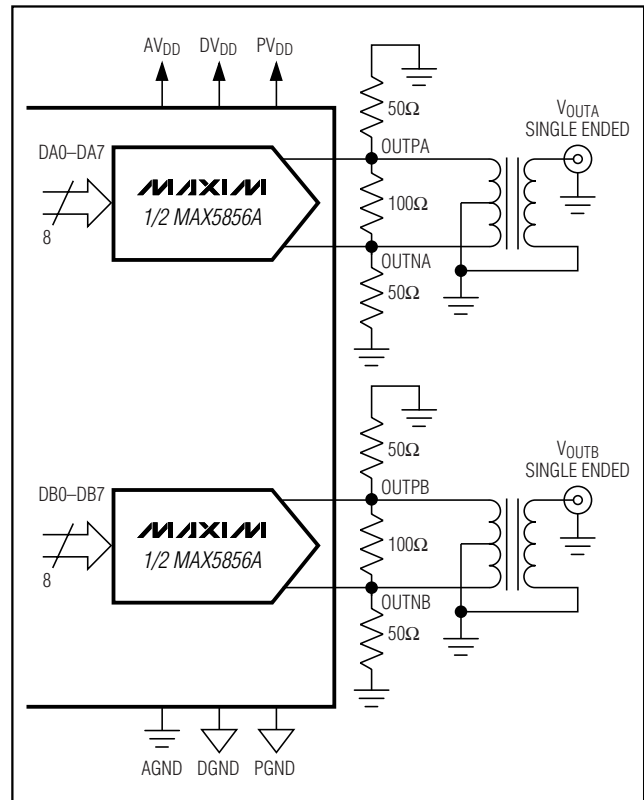


Figure 8. Application with Output Transformer Performing Differential to Single-Ended Conversion

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Differential DC-Coupled Configuration

Figure 9 shows the MAX5856A output operating in differential DC-coupled mode. This configuration can be used in communication systems employing analog quadrature upconverters and requiring a baseband sampling, dual-channel, high-speed DAC for I/Q synthesis. In these applications, information bandwidth can extend from 10MHz down to several hundred kilohertz. DC-coupling is desirable in order to eliminate long discharge time constants that are problematic with large, expensive coupling capacitors. Analog quadrature upconverters have a DC common-mode input requirement of typically 0.7V to 1.0V. The MAX5856A differential I/Q outputs can maintain the desired full-scale signal level at the required 0.7V to 1.0V DC common-mode voltage when powered from a single 2.85V ($\pm 5\%$) supply. The MAX5856A meets this low-power requirement with minimal reduction in dynamic range while eliminating the need for level-shifting resistor networks.

Power Supplies, Bypassing, Decoupling, and Layout

Grounding and power-supply decoupling strongly influence the MAX5856A performance. Unwanted digital crosstalk can couple through the input, reference, power-supply, and ground connections, which can affect dynamic specifications, like signal-to-noise ratio or spurious-free dynamic range. In addition, electromagnetic interference (EMI) can either couple into or be generated by the MAX5856A. Observe the grounding and power-supply decoupling guidelines for high-speed, high-frequency applications. Follow the power-supply and filter configuration to achieve optimum dynamic performance.

Use of a multilayer printed circuit (PC) board with separate ground and power-supply planes is recommended. Run high-speed signals on lines directly above the ground plane. The MAX5856A has separate analog and digital ground buses (AGND, PGND, and DGND, respectively). Provide separate analog, digital, and clock ground sections on the PC board with only one point connecting the three planes. The ground connection points should be located underneath the device and connected to the exposed paddle. Run digital signals above the digital ground plane and analog/clock signals above the analog/clock ground plane. Digital signals should be kept away from sensitive analog, clock, and reference inputs. Keep digital signal paths short and metal trace lengths matched to avoid propagation delay and data skew mismatch.

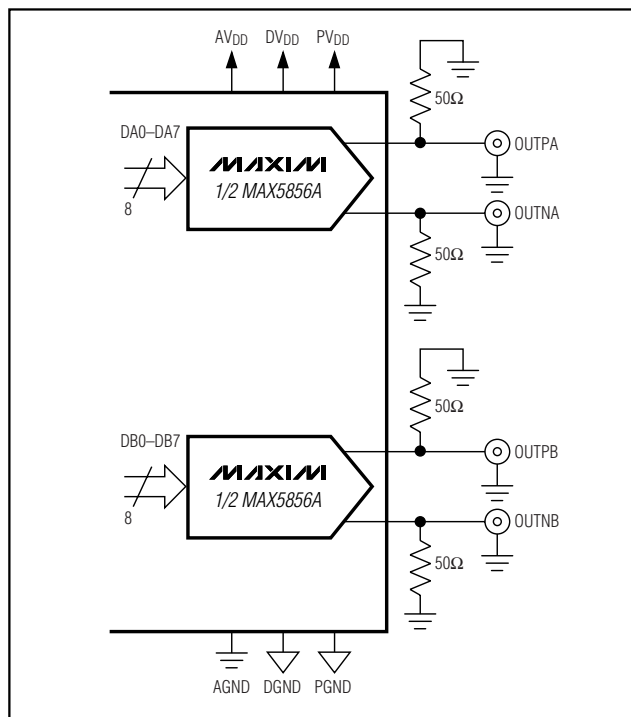


Figure 9. Application with DC-Coupled Differential Outputs

The MAX5856A includes three separate power-supply inputs: analog (AVDD), digital (DVDD), and clock (PVDD). Use a single linear regulator power source to branch out to three separate power-supply lines (AVDD, DVDD, PVDD) and returns (AGND, DGND, PGND). Filter each power-supply line to the respective return line using LC filters comprising ferrite beads and 10μF capacitors. Filter each supply input locally with 0.1μF ceramic capacitors to the respective return lines.

Note: To maintain the dynamic performance of the *Electrical Characteristics*, ensure the voltage difference between DVDD, AVDD, and PVDD does not exceed 150mV.

Thermal Characteristics and Packaging

Thermal Resistance

48-lead TQFP-EP:

$$\theta_{JA} = 27.6^{\circ}\text{C/W}$$

Keep the device junction temperature below +125°C to meet specified electrical performance. Lower the power-supply voltage to maintain specified performance when the DAC update rate approaches 300Msps and the ambient temperature equals +85°C.

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

The MAX5856A is packaged in a 48-pin TQFP-EP package, providing design flexibility, increased thermal efficiency, and optimized AC performance of the DAC. The EP enables the implementation of grounding techniques necessary to ensure highest performance.

In this package, the data converter die is attached to an EP lead frame with the back of this frame exposed at the package bottom surface, facing the PC board side of the package. This allows a solid attachment of the package to the PC board with standard infrared (IR)-flow soldering techniques. A specially created land pattern on the PC board, matching the size of the EP, ensures the proper attachment and grounding of the DAC. Designing vias into the land area and implementing large ground planes in the PC board design achieve optimal DAC performance. Use an array of 3 x 3 (or greater) vias ($\leq 0.3\text{mm}$ diameter per via hole and 1.2mm pitch between via holes) for this 48-pin TQFP-EP package.

Dynamic Performance Parameter Definitions

Total Harmonic Distortion (THD)

THD is the ratio of the RMS sum of all essential harmonics (within a Nyquist window) of the input signal to the fundamental itself. This can be expressed as:

$$\text{THD} = 20 \times \log \left(\frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + \dots + V_N^2}}{V_1} \right)$$

where V_1 is the fundamental amplitude, and V_2 through V_N are the amplitudes of the 2nd through Nth order harmonics.

Spurious-Free Dynamic Range (SFDR)

SFDR is the ratio of RMS amplitude of the carrier frequency (maximum signal component) to the RMS value of the next-largest spectral component. SFDR is usually measured in dBc with respect to the carrier frequency amplitude or in dBFS with respect to the DAC's full-scale range. Depending on its test condition, SFDR is observed within a predefined window or to Nyquist.

Multitone Power Ratio (MTPR)

A series of equally spaced tones are applied to the DAC with one tone removed from the center of the range. MTPR is defined as the worst-case distortion (usually a 3rd-order harmonic product of the fundamental frequencies), which appears as the largest spur at the frequency of the missing tone in the sequence. This test can be performed with any number of input tones; however, four and eight tones are among the most

common test conditions for CDMA- and GSM/EDGE-type applications.

Intermodulation Distortion (IMD)

The two-tone IMD is the ratio expressed in dBc of either output tone to the worst 3rd-order (or higher) IMD products.

Static Performance Parameter Definitions

Integral Nonlinearity (INL)

Integral nonlinearity (INL) is the deviation of the values on an actual transfer function from a line drawn between the end points of the transfer function, once offset and gain errors have been nullified. For a DAC, the deviations are measured at every individual step.

Differential Nonlinearity (DNL)

Differential nonlinearity (DNL) is the difference between an actual step height and the ideal value of 1 LSB. A DNL error specification ≥ -1 LSB guarantees a monotonic transfer function.

Offset Error

Offset error is the current flowing from positive DAC output when the digital input code is set to zero. Offset error is expressed in LSBs.

Gain Error

A gain error is the difference between the ideal and the actual full-scale output current on the transfer curve, after nullifying the offset error. This error alters the slope of the transfer function and corresponds to the same percentage error in each step. The ideal current is defined by reference voltage at $V_{\text{REF0}} / I_{\text{REF}} \times 32$.

Settling Time

The settling time is the amount of time required from the start of a transition until the DAC output settles to its new output value (within the converter's specified accuracy).

Glitch Impulse

A glitch is generated when a DAC switches between two codes. The largest glitch is usually generated around the midscale transition, when the input pattern transitions from 011...111 to 100...000. This occurs due to timing variations between the bits. The glitch impulse is found by integrating the voltage of the glitch at the midscale transition over time. The glitch impulse is usually specified in pV-s.

Chip Information

TRANSISTOR COUNT: 178,376

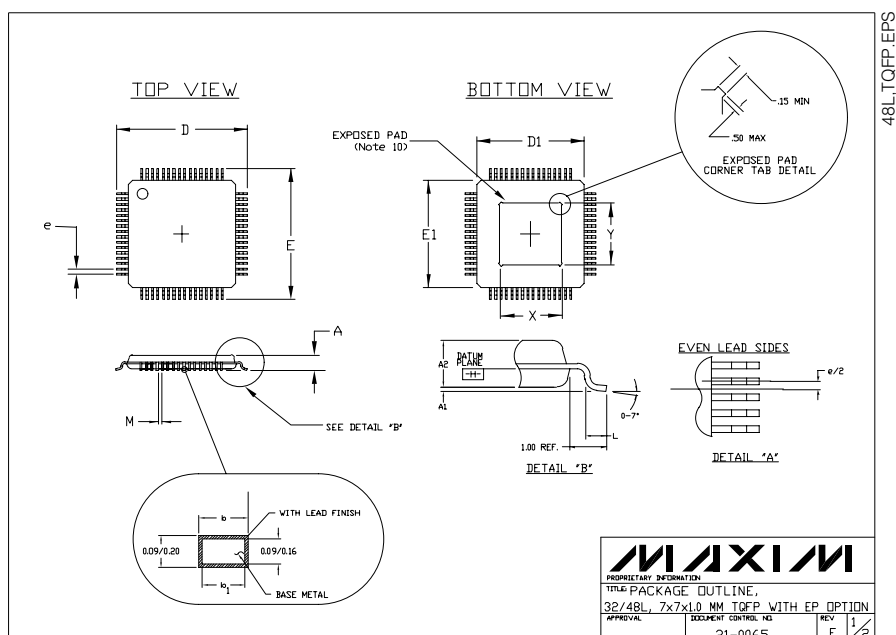
PROCESS: CMOS

Dual 8-Bit, 300Msps DAC with 4x/2x/1x Interpolation Filters and PLL

Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to www.maxim-ic.com/packages.)

MAX5856A



NOTES:

1. ALL DIMENSIONS AND TOLERANCING CONFORM TO ANSI Y14.5-1982.
2. DATUM PLANE (---) IS LOCATED AT MOLD PARTING LINE AND COINCIDENT WITH LEAD, WHERE LEAD EXITS PLASTIC BODY AT BOTTOM OF PARTING LINE.
3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTRUSION IS 0.254 MM ON D1 AND E1 DIMENSIONS.
4. THE TOP OF PACKAGE IS SMALLER THAN THE BOTTOM OF PACKAGE BY 0.15 MILLIMETERS.
5. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 MM TOTAL IN EXCESS OF THE b DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. CONTROLLING DIMENSION: MILLIMETER.
7. THIS OUTLINE CONFORMS TO JEDEC PUBLICATION 95 REGISTRATION MO-136, VARIATIONS AC AND AE.
8. LEADS SHALL BE COPLANAR WITHIN .004 INCH.
9. EXPOSED DIE PAD SHALL BE COPLANAR WITH BOTTOM OF PACKAGE WITHIN 2 MILS (.05 MM).
10. DIMENSIONS X & Y APPLY TO EXPOSED PAD (EP) VERSIONS ONLY. SEE INDIVIDUAL PRODUCT DATASHEET TO DETERMINE IF A PRODUCT USES EXPOSED PAD PACKAGE.

SYMBOL	JEDEC VARIATION					
	ALL DIMENSIONS IN MILLIMETERS					
	AC			AE		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	~	~	1.20	~	~	1.20
A1	0.05	0.10	0.15	0.05	0.10	0.15
A2	0.95	1.00	1.05	0.95	1.00	1.05
D	9.00 BSC.			9.00 BSC.		
D1	7.00 BSC.			7.00 BSC.		
E	9.00 BSC.			9.00 BSC.		
E1	7.00 BSC.			7.00 BSC.		
L	0.45	0.60	0.75	0.45	0.60	0.75
M	0.15	~	~	0.14	~	~
N	32			48		
e	0.80 BSC.			0.50 BSC.		
b	0.30	0.37	0.45	0.17	0.22	0.27
b1	0.30	0.35	0.40	0.17	0.20	0.23
*X	3.20	3.50	3.80	3.70	4.00	4.30
*Y	3.20	3.50	3.80	3.70	4.00	4.30

* EXPOSED PAD (Note 10)

JEDEC VARIATION					
TITL: PACKAGE OUTLINE, 32/48L, 7x7x1.0 MM TQFP WITH EP OPTION					
APPROVAL:	DOCUMENT CONTROL NO.	21-0065	REV	E	2/2

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